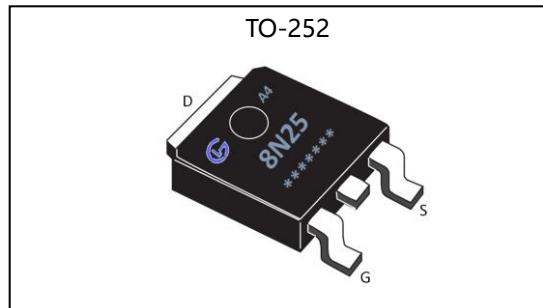


Silicon N-Channel Power MOSFET

General Description :

GL8N25A4, the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-252, which accords with the RoHS standard.

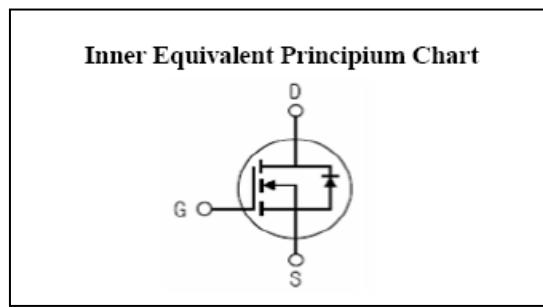
V _{DSS}	250	V
I _D	8	A
P _D (T _C =25°C)	83	W
R _{DS(ON).TYP.}	0.40	Ω

**Features :**

- Fast Switching
- Low ON Resistance(R_{dson}≤0.47Ω)
- Low Gate Charge (Typical Data:12nC)
- Low Reverse transfer capacitances(Typical:7pF)
- 100% Single Pulse avalanche energy Test

Applications:

- Automotive、DC Motor Control and Class D Amplifier

**Absolute (T_c=25°C unless otherwise specified) :**

Symbol	Parameter	Rating	Units
V _{DSS}	Drain-to-Source Voltage	250	V
I _D	Continuous Drain Current	8	A
	Continuous Drain Current T _C =100 °C	5	A
I _{DM} ^{a1}	Pulsed Drain Current	32	A
V _{GS}	Gate-to-Source Voltage	±30	V
E _{As} ^{a2}	Single Pulse Avalanche Energy	290	mJ
E _{Ar} ^{a1}	Avalanche Energy ,Repetitive	30	mJ
I _{AR} ^{a1}	Avalanche Current	2.5	A
dv/dt ^{a3}	Peak Diode Recovery dv/dt	5.0	V/ns
P _D	Power Dissipation	83	W
	Derating Factor above 25°C	0.67	W/°C
T _J , T _{stg}	Operating Junction and Storage Temperature Range	150 , -55 to 150	°C
T _L	Maximum Temperature for Soldering	300	°C

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device



GL8N25A4

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Silicon N-Channel Power MOSFET

Thermal Characteristics

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.51	°C / W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C / W

Electrical Characteristics ($T_c = 25^\circ C$ unless otherwise specified) :

OFF Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	250	--	--	V
$\Delta V_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu A$, Reference $25^\circ C$	--	0.2	--	V/ $^\circ C$
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=250V, V_{GS}=0V, T_a=25^\circ C$	--	--	1.0	μA
		$V_{DS}=200V, V_{GS}=0V, T_a=125^\circ C$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30V$	--	--	-100	nA

ON Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=4A$	--	0.4	0.47	Ω
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	--	4.0	V
g_f	Forward Trans conductance	$V_{DS}=15V, I_D=8A$	--	6.5	--	S

Pulse width < 380μs; duty cycle < 2%.

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=25V$ $f=1.0MHz$	--	620	--	pF
C_{oss}	Output Capacitance		--	80	--	
C_{rss}	Reverse Transfer Capacitance		--	7	--	

Resistive Switching Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=8A, V_{DD}=125V$ $V_{GS}=10V, R_g=25\Omega$	--	10	--	ns
t_r	Rise Time		--	12	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	28	--	
t_f	Fall Time		--	14	--	
Q_g	Total Gate Charge	$I_D=8A, V_{DD}=125V$ $V_{GS}=10V$	--	12	--	nC
Q_{gs}	Gate to Source Charge		--	4.0	--	
Q_{gd}	Gate to Drain ("Miller")Charge		--	4.0	--	

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**GL8N25A4**

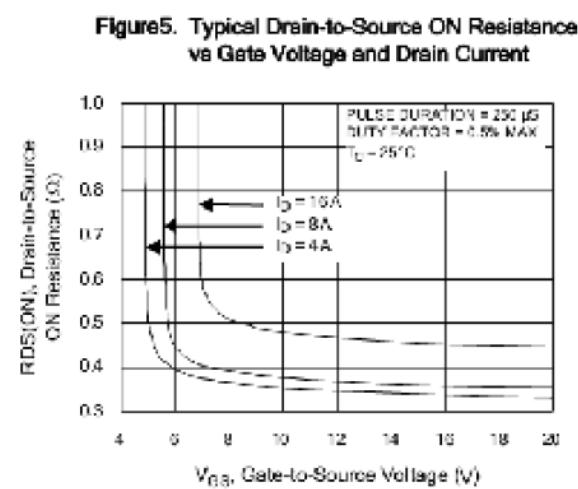
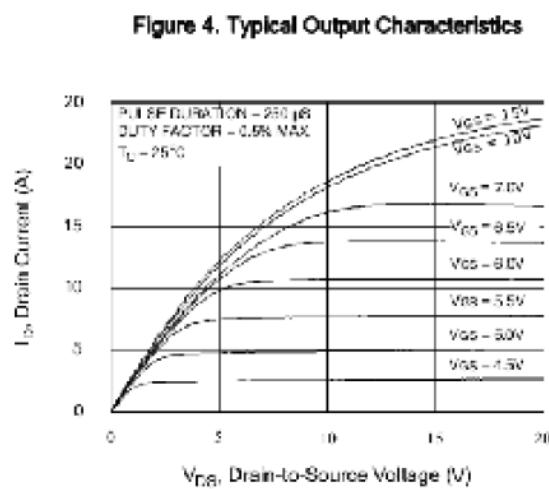
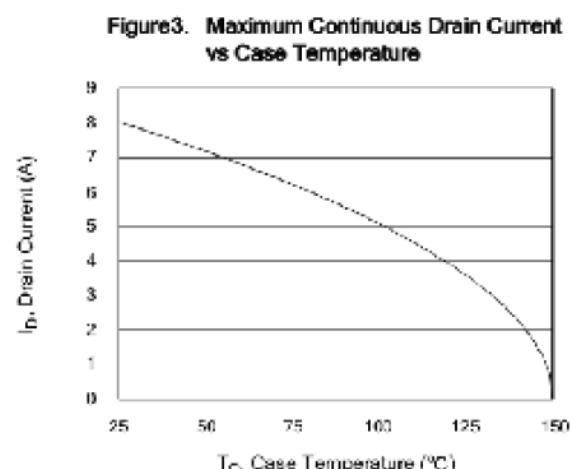
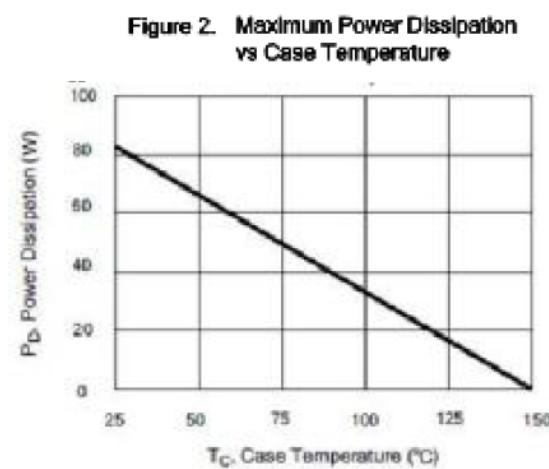
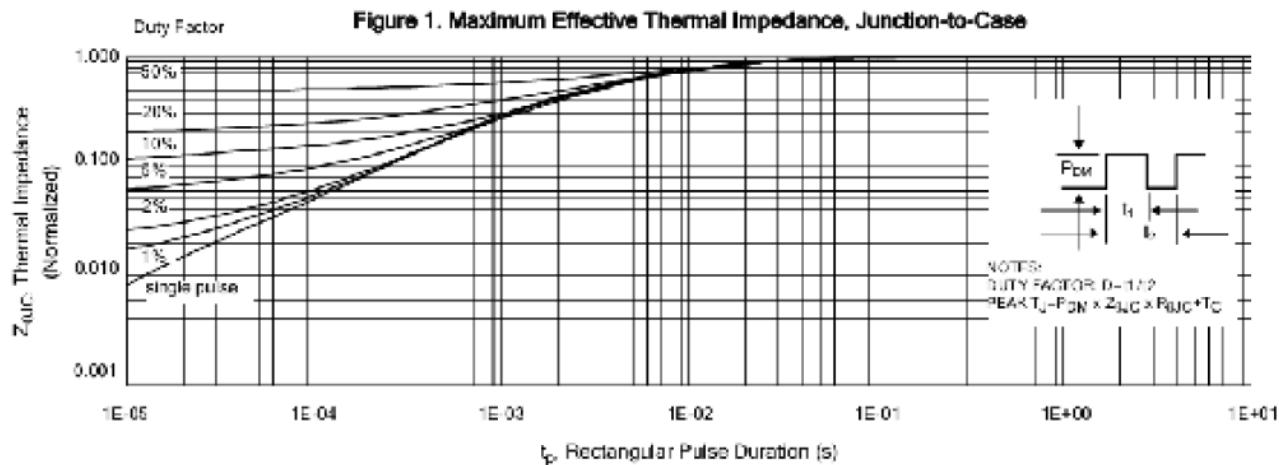
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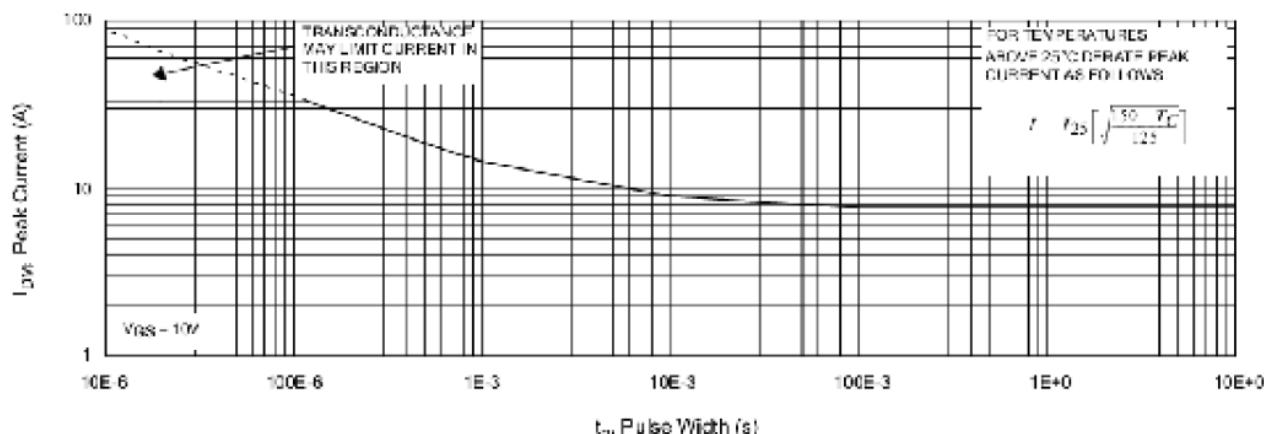
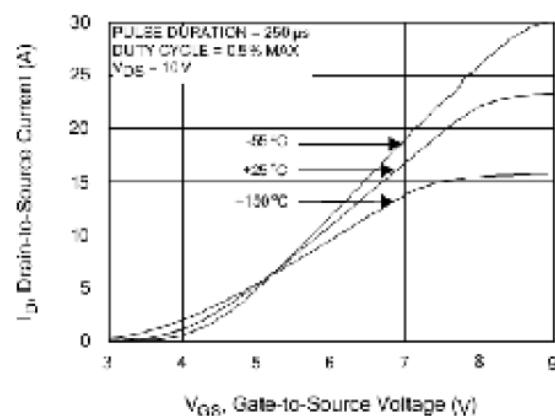
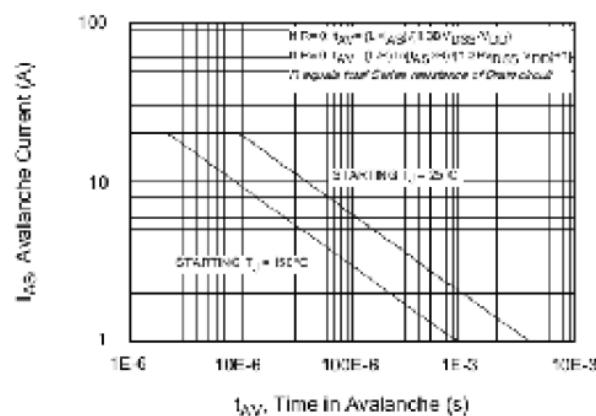
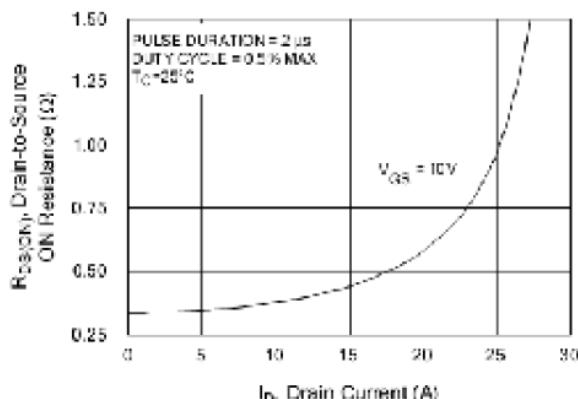
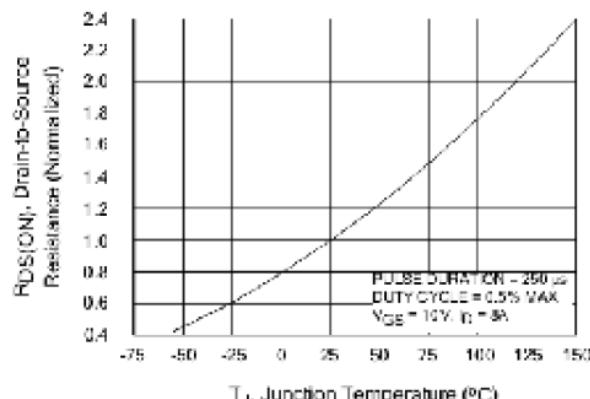
*Silicon N-Channel Power MOSFET***Source-Drain Diode Characteristics**

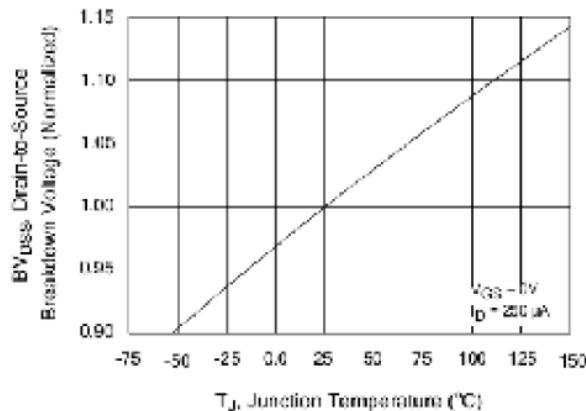
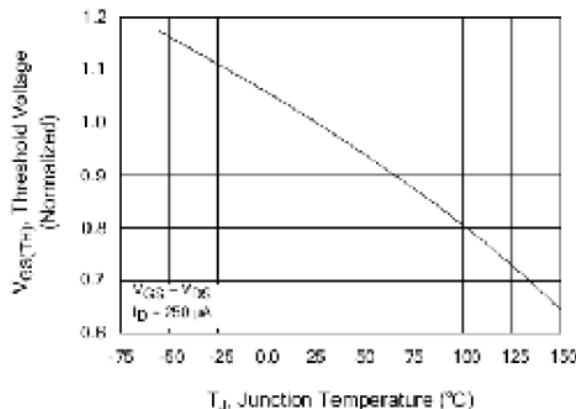
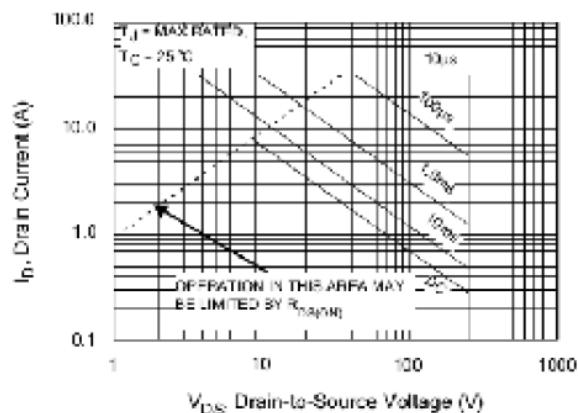
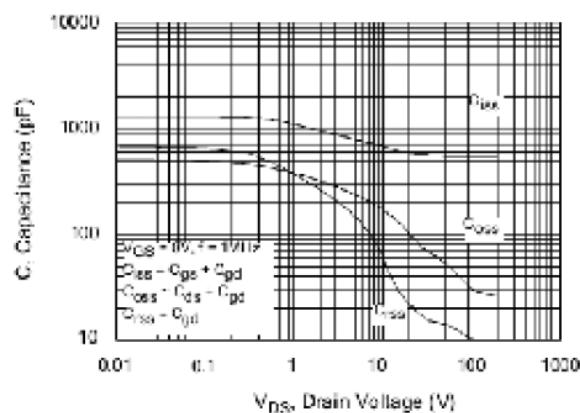
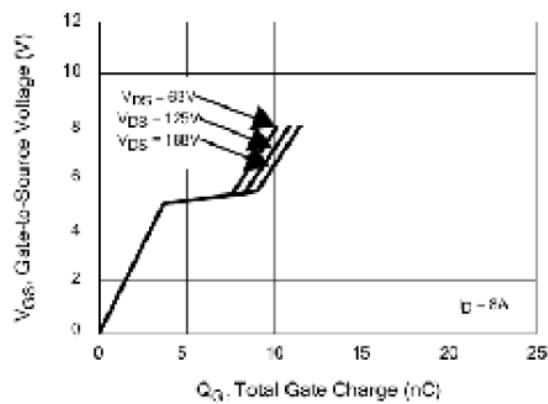
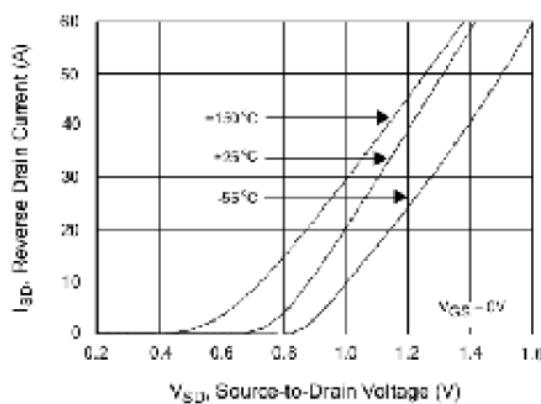
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _{SD}	Continuous Source Current (Body Diode)		--	--	8	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	32	A
V _{SD}	Diode Forward Voltage	I _S =8A, V _{GS} =0V	--	--	1.5	V
t _{rr}	Reverse Recovery Time	I _S =8A, T _j =25°C	--	150	--	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt=100A/μs, V _{GS} =0V	--	0.73	--	μC

a1 : Repetitive rating; pulse width limited by maximum junction temperature

a2 : L=4mH, I_D=7.6A, R_g=25Ω Start T_j=25°Ca3 : I_{SD}=8A, di/dt ≤ 200A/us, V_{DD}≤BV_{DS}, Start T_j=25°C

Silicon N-Channel Power MOSFET
Characteristics Curve :


Silicon N-Channel Power MOSFET
Figure 6. Maximum Peak Current Capability

Figure 7. Typical Transfer Characteristics

Figure 8. Unclamped Inductive Switching Capability

Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature


Silicon N-Channel Power MOSFET
Figure 11. Typical Breakdown Voltage vs Junction Temperature

Figure 12. Typical Threshold Voltage vs Junction Temperature

Figure 13. Maximum Forward Bias Safe Operating Area

Figure 14. Typical Capacitance vs Drain-to-Source Voltage

Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

Figure 16. Typical Body Diode Transfer Characteristics


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